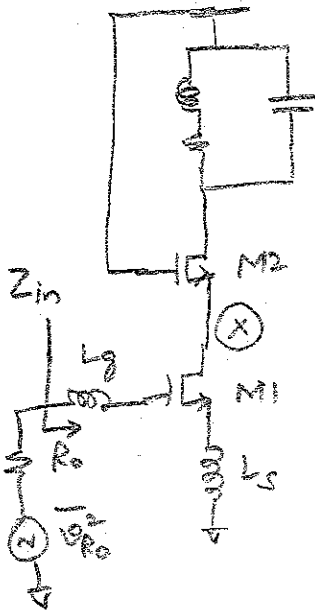


Noise performance of source degenerated LNA:



- Assume frequency of operation = ω_0
- Input impedance at ω_0

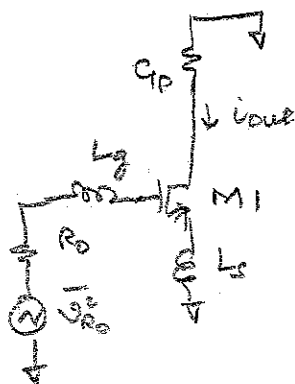
$$Z_{in} = \frac{g_m L_s}{C_{gs}} + j \left[\omega_0 (L_s + L_g) - \frac{1}{\omega_0 C_{gs}} \right]$$

Set $\omega_0 L_s = R_0$
for power match

resonance at ω_0

$$\Rightarrow \omega_0 = \frac{1}{\sqrt{(L_s + L_g) C_{gs}}}$$

- At ω_0 , the load is a pure resistor R_p (or conductance G_p)
- For the present, we will assume that the cascode device does not contribute noise. Of course, this is not accurate; however, as long as the parasitic capacitance C_x is small, M2's noise contribution can be ignored.
- The circuit for noise calculations is then:



→ We have a total of three noise sources:

- source noise $\overline{V_{R_0}^2}$
- drain noise of M1 $\overline{i_d^2} = 4kT\gamma g_{m0} \Delta f$
- gate noise of M1 $\overline{i_g^2} = 4kT\delta g_g \Delta f$

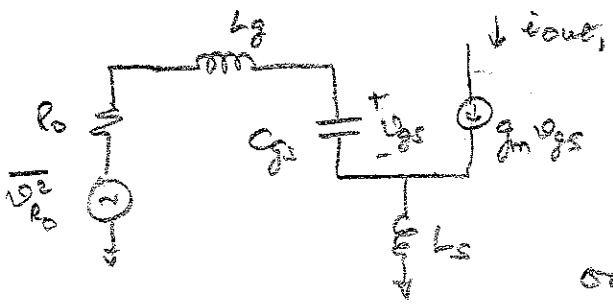
→ V_{R_0} is independent and hence uncorrelated to i_d and i_g .

→ i_g and i_d are correlated through a correlation coefficient c which is defined as follows:

$$\overline{i_g i_d^*} = c \sqrt{\overline{i_g^2} \overline{i_d^2}} \quad \left(\text{Van der Ziel: } c = -j0.395 \text{ for long-channel, saturated FET} \right)$$

→ We shall consider each noise source separately and pay attention to correlation between i_d and i_g when calculating the total mean-square noise current $\overline{i_{out,tot}^2}$

(a) Source noise contribution



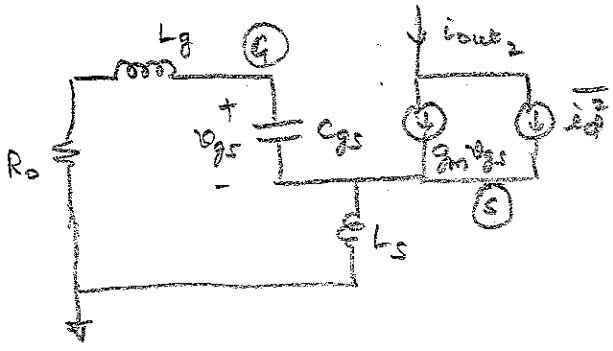
Define $Q = \frac{\omega_0 (L_s + L_g)}{\omega_0 L_s + R_o} = \frac{1}{\omega_0 C_{gs} (R_o + \omega_0 L_s)}$

$Q = \frac{\omega_0 (L_s + L_g)}{2R_o} = \frac{1}{2\omega_0 C_{gs} R_o}$

$v_{gs} = Q v_{ro} \Rightarrow i_{out,1} = g_m v_{gs} = Q g_m v_{ro}$

$i_{out,1} = Q g_m v_{ro}$

(b) Drain noise contribution:



KCL at (S): $g_m v_{gs} + i_d + s C_{gs} v_{gs} = \frac{v_s}{s L_s}$

KCL at (G): $\frac{v_{gs} + v_s}{R_o + s L_g} + s C_{gs} v_{gs} = 0$

Solve: $v_{gs} = - \frac{s L_s i_d}{1 + s (L_s g_m + C_{gs} R_o) + s^2 (L_s + L_g) C_{gs}}$

At $s = j\omega_0$:

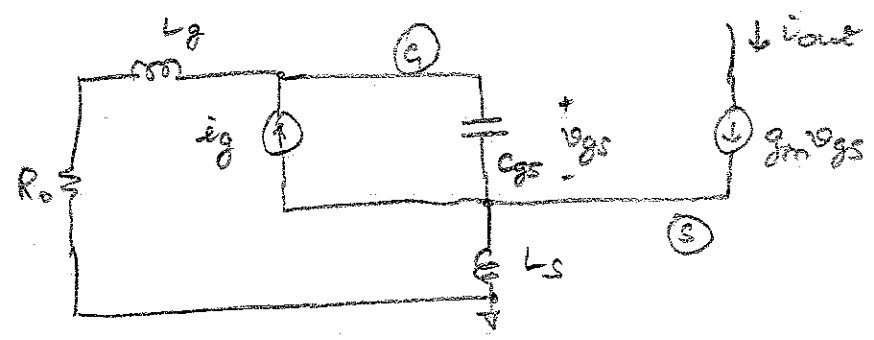
$v_{gs} = - \frac{j\omega_0 L_s i_d}{1 - \omega_0^2 (L_g + L_s) C_{gs} + j\omega_0 (\frac{g_m L_s}{C_{gs}} + R_o) C_{gs}}$

Out at $\omega_0 \rightarrow [1 - \omega_0^2 (L_g + L_s) C_{gs}] + j\omega_0 (\frac{g_m L_s}{C_{gs}} + R_o) C_{gs}$
 $= - \frac{L_s / C_{gs} i_d}{2 R_o}$

$$\Rightarrow i_{out2} = i_d + g_m v_{gs} = i_d - \frac{g_m L_s / C_{gs}}{2R_o} i_d = i_d - \frac{R_o}{2L_o} i_d$$

$$\Rightarrow i_{out2} = \frac{1}{2} i_d$$

(c) Gate noise contribution :



KCL at (5) : $i_g + \frac{v_s}{sL_s} = (g_m + sC_{gs}) v_{gs}$

KCL at (4) : $i_g = sC_{gs} v_{gs} + \frac{v_{gs} + v_s}{R_o + sL_g}$

Solve : $v_{gs} = \frac{R_o + s(L_s + L_g)}{1 + s^2(L_s + L_g)C_{gs} + s(R_o C_{gs} + g_m L_s)}$

At $s = j\omega_0$: $v_{gs} = \frac{R_o + j\omega_0(L_s + L_g)}{R_o + j\omega_0(L_s + L_g)}$

0 ← at ω_0 $[1 - \omega_0^2(L_s + L_g)C_{gs}] + s(R_o C_{gs} + g_m L_s)$

$$= \frac{[1 + j\omega_0(L_s + L_g)/R_o] R_o}{j\omega_0 (R_o + \frac{g_m L_s}{C_{gs}}) C_{gs}} i_g$$

$$Q = \frac{1}{2\omega_0 R_o C_{gs}} = \frac{\omega_0(L_s + L_g)}{2R_o}$$

$$= i_g \frac{1 + j2Q}{j} \cdot Q R_o = (2Q - j) \frac{1}{2\omega_0 C_{gs}} i_g$$

$$\Rightarrow i_{out3} = g_m v_{gs} = \frac{1}{2} (2Q - j) \frac{g_m}{\omega_0 C_{gs}} i_g \Rightarrow i_{out3} = \frac{1}{2} (2Q - j) \frac{\omega_0}{\omega_0} i_g$$

$$i_{out, tot} = i_{out_1} + i_{out_2} + i_{out_3}$$

$$= \beta g_m v_{R_0} + \frac{1}{2} i_d + \frac{1}{2} (2R - j) \frac{\omega_T}{\omega_0} i_g$$

To find mean-square output noise current:

Note $\overline{|X+Y|^2} = \overline{(X+Y)(X+Y)^*}$

$$= \overline{|X|^2} + \overline{|Y|^2} + \overline{XY^* + X^*Y}$$

$$= \overline{|X|^2} + \overline{|Y|^2} + 2\text{Re}(XY^*)$$

$$\therefore \overline{i_{out, tot}^2} = \beta^2 g_m^2 \overline{v_{R_0}^2} + \frac{1}{4} \overline{i_d^2} + \frac{1}{4} |2R - j|^2 \left(\frac{\omega_T}{\omega_0}\right)^2 \overline{i_g^2}$$

$$+ \frac{1}{4} 2\text{Re} \left\{ \overline{i_d^* (2R - j) \frac{\omega_T}{\omega_0} i_g} \right\}$$

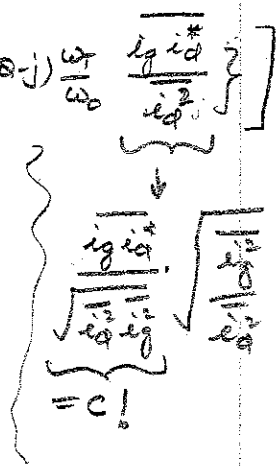
$$= \beta^2 g_m^2 \overline{v_{R_0}^2} + \frac{1}{4} \overline{i_d^2} + \frac{1}{4} (4R^2 + 1) \left(\frac{\omega_T}{\omega_0}\right)^2 \overline{i_g^2}$$

$$+ \frac{2}{4} \text{Re} \left\{ (2R - j) \frac{\omega_T}{\omega_0} \overline{i_g i_d^*} \right\}$$

$$= \beta^2 g_m^2 \overline{v_{R_0}^2} + \frac{1}{4} \overline{i_d^2} \left[1 + (4R^2 + 1) \left(\frac{\omega_T}{\omega_0}\right)^2 \frac{\overline{i_g^2}}{\overline{i_d^2}} + 2\text{Re} \left\{ (2R - j) \frac{\omega_T}{\omega_0} \frac{\overline{i_g i_d^*}}{\overline{i_d^2}} \right\} \right]$$

Also, $\frac{\overline{i_g^2}}{\overline{i_d^2}} = \frac{4kT \delta g_g \Delta f}{4kT \gamma_{gdo} \Delta f} = \frac{\delta g_g}{\gamma_{gdo}}$

and $c = -j0.395 = -j|c|$



$$\therefore \overline{i_{out, tot}^2} = \beta^2 g_m^2 \overline{v_{R_0}^2} + \frac{1}{4} \overline{i_d^2} \left[1 + (4R^2 + 1) \frac{\omega_T^2}{\omega_0^2} \frac{\delta g_g}{\gamma_{gdo}} - 2 \left(\frac{\omega_T}{\omega_0}\right) |c| \sqrt{\frac{\delta g_g}{\gamma_{gdo}}} \right]$$

Finally, substitute $g_g = \frac{\omega^2 C_{gs}^2}{5g_{do}}$ and $g_m = \omega_T C_{gs}$

$$\Rightarrow \overline{i_{out}^2}_{tot} = Q^2 g_m^2 \overline{v_{R_o}^2} + \frac{1}{4} \overline{i_d^2} \left[1 + (4Q^2 + 1) \left(\frac{g_m}{g_{d0}} \right)^2 \frac{\delta}{5\gamma} - 2|c| \frac{g_m}{g_{d0}} \sqrt{\frac{\delta}{5\gamma}} \right]$$

Finally, $F = \frac{\overline{i_{out}^2}_{tot}}{\overline{i_{out}^2}_{source}}$

$$\Rightarrow F = 1 + \underbrace{\frac{1}{4Q^2 g_m^2} \frac{\overline{i_d^2}}{\overline{v_{R_o}^2}}}_{\frac{1}{2Q} \frac{1}{2Q g_m R_o} \frac{\gamma g_{d0}}{g_m}} \left[1 + (4Q^2 + 1) \left(\frac{g_m}{g_{d0}} \right)^2 \frac{\delta}{5\gamma} - 2|c| \frac{g_m}{g_{d0}} \sqrt{\frac{\delta}{5\gamma}} \right]$$

$$\frac{1}{2Q} \frac{1}{2Q g_m R_o} \frac{\gamma g_{d0}}{g_m} = \frac{1}{2Q} \left(\frac{\omega_0}{\omega_T} \right) \frac{\gamma g_{d0}}{g_m}$$

$$\Rightarrow F = 1 + \left(\frac{\omega_0}{\omega_T} \right) \frac{\gamma g_{d0}}{g_m} \frac{1}{2Q} \left[1 + (4Q^2 + 1) \left(\frac{g_m}{g_{d0}} \right)^2 \frac{\delta}{5\gamma} - 2|c| \frac{g_m}{g_{d0}} \sqrt{\frac{\delta}{5\gamma}} \right]$$

S_N : scaling coefficient, dependent only on Q and process technology.

- This is a lower bound on the total noise. Parasitic resistances (due to layout, gate resistance, inductor resistances) will add to F . The cascade device noise also adds due to parasitic capacitance at the cascade node.

$F = 1 + \left(\frac{\omega_0}{\omega_T} \right) S_N$

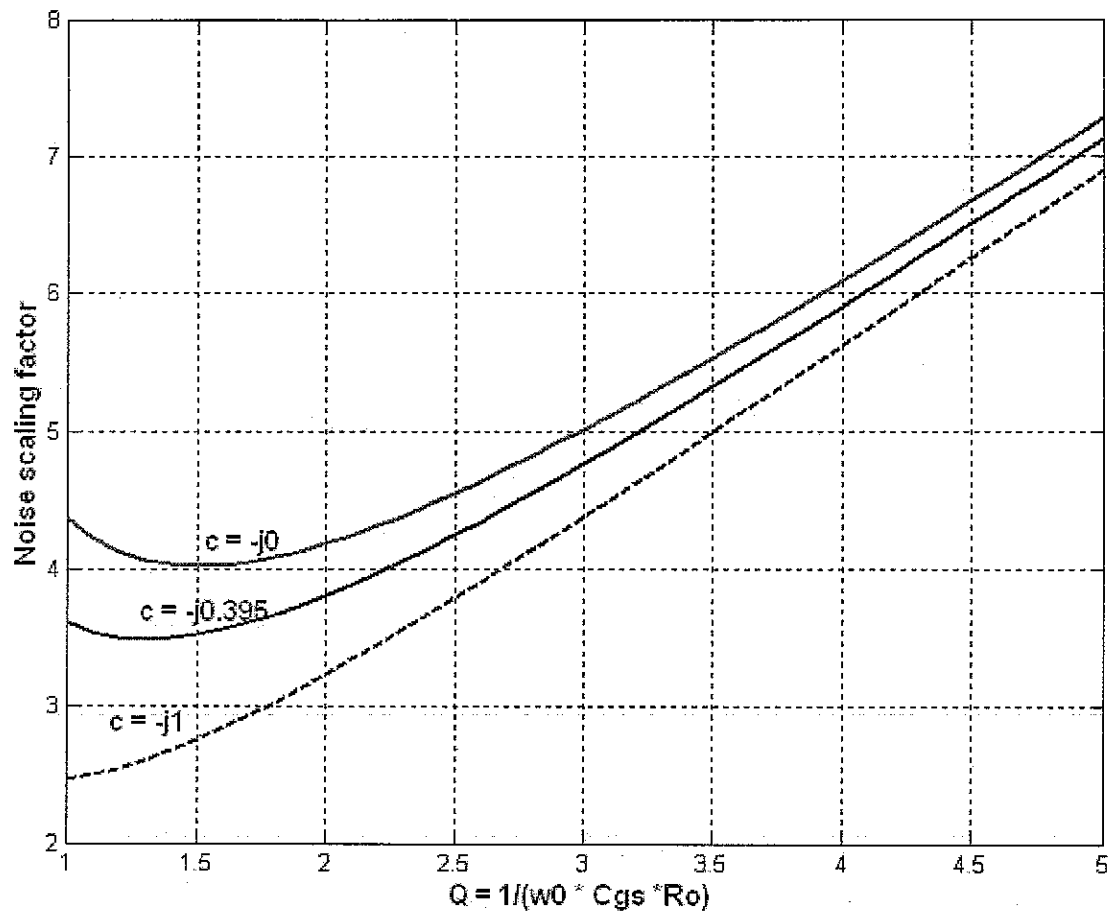
for different c 's

See plot of S_N vs. Q on the next page. We have assumed the following:

$$\frac{g_m}{g_{d0}} = \frac{1}{1.8}, \quad \gamma = 3, \quad \delta = 2\gamma = 6$$

(Long channel approx.) $\omega_E = \frac{3}{2} \frac{\mu_n}{L^2} (V_{GS} - V_T)$

$\Rightarrow \omega_E \propto \frac{1}{L^2} \rightarrow$ performance improves dramatically with CMOS device scaling.

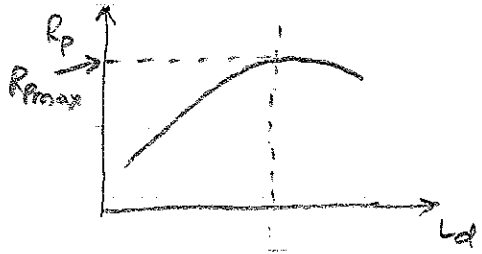


LNA Design procedure :

Specifications :

Min. voltage gain A_v	e_g	$> 20dB$
Operating frequency ω_0		$5GHz$
source impedance R_0		50Ω
Max. power dissipation P_{dis}		$10mW$
Max. Noise Figure F		$2dB$
Min. IIP3 V_{IIP3} (or P_{IIP3})		$0dBm$
1dB compression V_{-1dB} (or P_{-1dB})		$-10dBm$
Supply voltage V_{dd}		$1.4V$

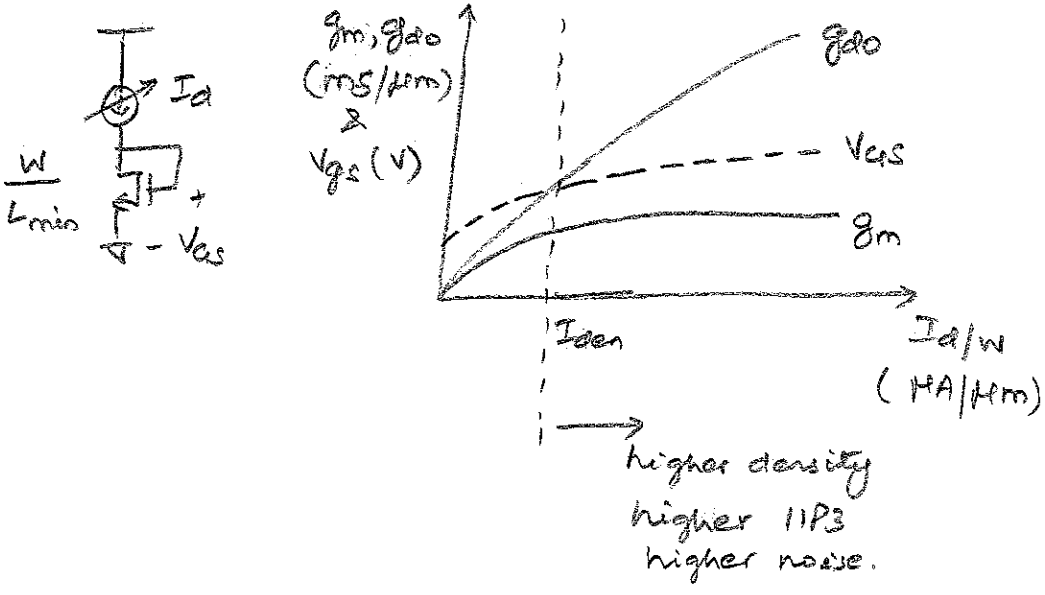
(1) First set R_p . In general, this is highly dependent on the process technology. A plot of R_p vs. L_d (the drain inductance might look like this :



Generally, we would pick an L_d which offers maximum R_p .

(2) From $A_v = G_m R_p$, calculate the effective transconductance G_m . Note that $G_m = \beta g_m$.

(3) For a minimum channel-length device, plot (by simulation or otherwise) g_m , g_{do} and V_{gs} as functions of current density I_d/W . One way to do this is :



Another option is to plot these ^{in Matlab} using analytical expressions:

- $I_D = \beta \frac{(V_{GS} - V_T)^2}{1 + \eta(V_{GS} - V_T)}$
- $g_m = \frac{\beta(V_{GS} - V_T)}{1 + \eta(V_{GS} - V_T)} \left[1 + \frac{1}{1 + \eta(V_{GS} - V_T)} \right]$
 $= \frac{I_D}{V_{GS} - V_T} \left[1 + \frac{1}{\eta(V_{GS} - V_T)} \right]$

where

- $\beta = \frac{1}{2} \mu_0 C_{ox} \frac{W}{L}$
- and
- $\eta = \theta + \frac{\mu_0}{2g_{sat}L}$
- $\theta \approx \frac{10^{-2}}{E_{ox}} \sqrt{-1}$

$\mu_0, C_{ox}, E_{ox}, \theta$ and g_{sat} can be found from the simulation model file.

- $g_{do} = 2\beta(V_{GS} - V_T)$

(4) Pick a current density I_{den} from the plot. We know from analysis that as $I_{den} \uparrow, (V_{GS} - V_T) \uparrow, F \uparrow$ because $g_{do}/g_m \uparrow$ and $11P3 \uparrow. \Rightarrow$ Noise vs. linearity trade-off

A good compromise is to operate the device in weak-to-moderate inversion i.e., $(V_{GS} - V_T) \sim 100-200mV$.

Once we know $(V_{GS} - V_T)$, pick off g_m from the graph. Note that this is a normalized g_m (mS/ μm)

(5) Under the assumption that the correlation coefficient c is known, find Q for minimum noise scaling factor.

Then, use $Q = \frac{1}{2\omega C_{gs} R_0}$ to find C_{gs}

and calculate W from $C_{gs} = \frac{2}{3} C_{ox} WL$

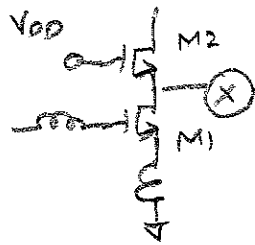
(6) Calculate the g_m : $g_m = W \cdot X$ (normalized g_m)



(7) Find $\omega_T = \frac{g_m}{C_{gs}}$ and use $R_{o2} = \omega_T L_s$ to find L_s

(8) Use $\omega_{o2}^2 = \frac{1}{(L_g + L_s)C_{gs}}$ to find L_g .

(9) For the cascode device, set W and L to be the same as that of M_1 as a starting point.

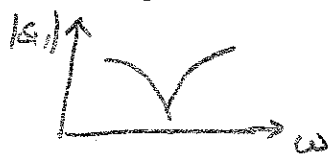


Usually, the gate of M_2 is tied to the power supply V_{DD} . Since we know the bias current $I_{Bias} = I_{DQ1} \cdot W_1$, and also the size of M_1 , the bias voltage

V_x is now fixed.

At this point, verify stability by simulation.

$|S_{11}|$ must not exhibit "frenzy" behavior - you should see something like



(10) Simulate to find A_v , F and $HP3$ and verify that they meet spec. Also check that P_{diss} is within spec.

If not, iterate steps (4) - (10).